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# CAPACITORS, FIXED, CHIPS, CERAMIC DIELECTRIC, TYPE I

## **BASED ON TYPE 1206**

ESCC Detail Specification No. 3009/022

Issue 8 September 2023



Document Custodian: European Space Agency - see https://escies.org



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DCR No.	CHANGE DESCRIPTION
1534	Specification updated to incorporate changes per DCR.





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#### 1 GENERAL

#### 1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, and test and inspection data for the component type variants and/or the range of components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

#### 1.2 <u>APPLICABLE DOCUMENTS</u>

The following documents form part of this specification and shall be read in conjunction with it:

(a) ESCC Generic Specification No. 3009.

#### 1.3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.

### 1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

#### 1.4.1 The ESCC Component Number

The ESCC Component Number shall be constituted as follows:

Example: 3009022014700JA

- Detail Specification Reference: 3009022
- Component Type Variant Number: 01 (as required)
- Characteristic code: Capacitance Value (470pF): 4700 (as required)
- Characteristic code: Capacitance Tolerance (±5%): J (as required)
- Rating code: Rated Voltage (25V): A (as required)



### 1.4.1.1 Characteristics and Ratings Codes

Characteristics and ratings to be codified as part of the ESCC Component Number shall be as follows:

(a) Rated Capacitance Value, C<sub>n</sub>, expressed by means of the following codes in accordance with ESCC Basic Specification No. 21700. The unit quantity shall be picofarad (pF).

Capacitance Value C <sub>n</sub> (pF)	Code
X.XX	XCXX
XX.X	XXCX
XXX	XXX0
XXX 10 <sup>1</sup>	XXX1
XXX 10 <sup>2</sup>	XXX2

(b) Capacitance Tolerance expressed by the following codes in accordance with ESCC Basic Specification No. 21700:

Tolerance (±)	Code Letter
0.25pF	С
0.5pF	D
1%	F
2%	G
5%	J
10%	K

(c) Rated Voltage, U<sub>R</sub>, expressed by the following codes:

Rated Voltage U <sub>R</sub> (V)	Code Letter
10	Y
16	X
25	Α
50	С
100	E



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#### 1.4.2 <u>Component Type Variants and Range of Components</u>

The component type variants and range of components applicable to this specification are as follows:

Variant	Style Capacitance	<u>.</u>	Terminal Mate	Weight	
Number		Range, Tolerance, Rated Voltage	End Terminations	Termination Finish	Max (g)
01	1206	See Note 1	Ag/Pd	No finish (Note 2)	0.15
03	1206	See Note 1	Ag/Pd/Pt	No finish (Note 2)	0.15
05	1206	See Note 1	Ag + Ni barrier	Sn60, Sn62 or Sn63 solder dip	0.15
06	1206	See Note 1	Ag + Ni barrier	Sn/Pb plating (Note 3)	0.15
08	1206	See Note 1	Ag + Ni barrier	Au plating (Note 2)	0.15

### **NOTES:**

1. Available rated voltages, capacitance values and tolerances are as follows:

Rated Voltage U <sub>R</sub>	Capacitance Range C <sub>n</sub> (pF)		
(V)	Min	Max	
100	1	3900	
50	1	5600	
25	1	5600	
16	1	6800	
10	1	27000	

Available Capacitance values for each Rated Voltage are as defined by the E12 to E96 series; however, any capacitance value within each specified capacitance range may be available on request.

Capacitance tolerances available are:

- for  $C_n < 10pf$ : 0.25pF, 0.5pF
- for  $C_n \ge 10pf$ : 1% 2% 5% 10%
- 2. Variants 01, 03 and 08 are not suitable for solder assembly methods. They shall be assembled using glue or wire bond techniques.
- 3. Sn/Pb plating with tin content of 50% minimum and 97% maximum, remainder lead.



### 1.5 <u>MAXIMUM RATINGS</u>

The maximum ratings shall not be exceeded at any time during use or storage.

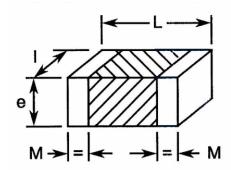
Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

Characteristics	Symbols	Maximum Ratings	Units	Remarks
Rated Voltage	U <sub>R</sub>	10, 16, 25, 50, 100	V	Note 1
Operating Temperature Range	Тор	-55 to +125	°C	Without derating. T <sub>amb</sub>
Storage Temperature Range	T <sub>stg</sub>	-55 to +125	°C	
Soldering Temperature	T <sub>sol</sub>	+260	°C	Note 2

#### NOTES:

- 1. As required; See Para. 1.4.2.
- 2. Duration 10 seconds maximum.

### 1.6 PHYSICAL DIMENSIONS



Symbols	Dimensions (mm)					
	Variants 01	, 03, 06, 08	Varia	nt 05		
	Min Max		Min	Max		
L	2.8	3.6	2.8	4.1		
I	1.3	1.9	1.3	2.4		
е	- 2.3		-	2.8		
М	0.2 0.75		0.2	0.75		

#### 1.7 <u>FUNCTIONAL DIAGRAM</u>





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#### 2 **REQUIREMENTS**

#### 2.1 **GENERAL**

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

#### 2.1.1 **Deviations from the Generic Specification**

#### Deviations from Qualification and Periodic Tests - Chart F4 2.1.1.1

Solderability: not applicable to Variants 01, 03 and 08.

#### 2.2 MARKING

The marking shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and as follows.

The information to be marked on the component or its primary package shall be:

- The ESCC qualified components symbol (for ESCC qualified components only). (a)
- The ESCC Component Number (see Para. 1.4.1). (b)
- Traceability information. (c)

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#### 2.3 <u>ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES</u>

Electrical measurements shall be performed at room, high and low temperatures.

#### 2.3.1 Room Temperature Electrical Measurements

The measurements shall be performed at  $T_{amb}$  = +22 ±3°C.

Characteristics	Symbols	Test Method and Conditions	Tolerance	Lin	Units	
			(±)	Min	Max	
Capacitance	CA	ESCC No. 3009				pF
			0.25pF	C <sub>n</sub> -0.25	C <sub>n</sub> +0.25	
			0.5pF	C <sub>n</sub> -0.5	C <sub>n</sub> +0.5	
			1%	0.99C <sub>n</sub>	1.01C <sub>n</sub>	
			2%	0.98C <sub>n</sub>	1.02C <sub>n</sub>	
			5%	0.95C <sub>n</sub>	1.05C <sub>n</sub>	
			10%	0.9C <sub>n</sub>	1.1C <sub>n</sub>	
Tangent of Loss	tgδ	ESCC No. 3009	All			
Angle		For C <sub>n</sub> < 50pF		-	Note 1	
		For C <sub>n</sub> ≥ 50pF		-	15 x10 <sup>-4</sup>	-
Insulation Resistance	Ri	ESCC No. 3009	All	100	-	GΩ
Voltage Proof	VP	ESCC No. 3009	All	2.5U <sub>R</sub>	-	V

#### NOTES:

For  $C_n < 50$ pF,  $tg\delta < 1.5 \times (150/C_n + 7) \times 10^{-4}$ , where the unit quantity for  $C_n$  is in pF.

#### 2.3.2 <u>High and Low Temperatures Electrical Measurements</u>

Characteristics	Symbols	Test Method and Conditions	Limits		Units
		(Note 1)	Min	Max	
Insulation Resistance	Rı	ESCC No. 3009 T <sub>amb</sub> = +125 ±2°C Note 2	10	-	GΩ
Temperature Coefficient	TC	ESCC No. 3009 T <sub>amb</sub> = -55 ±2°C, +20 ±2°C, +125 ±2°C Note 3			10 <sup>-6</sup> /°C
		For C <sub>n</sub> > 20pF	-30	+30	
		For C <sub>n</sub> ≤ 20pF	Not	te 4	

#### NOTES:

- The measurements shall be performed on a sample of 5 components from each manufacturing lot with 0 failures allowed. In the event of any failure a 100% inspection may be performed.
- 2. Guaranteed but not tested during Chart F3 of the Generic Specification; only tested in Temperature Characterisation during Chart F4 of the Generic Specification.
- 3. In the case of a 100% inspection, a 1% total percent defective is allowed.
- 4. Temperature Coefficient is not specified for  $C_n \le 20pF$  due to test equipment limitations.



### 2.4 <u>INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS</u>

Unless otherwise specified, the measurements shall be performed at  $T_{amb}$  = +22 ±3°C.

Unless otherwise specified the test methods and test conditions shall be as per the corresponding test defined in Para. 2.3.1 Room Temperature Electrical Measurements.

Test Reference per ESCC	Characteristics	Symbols	ols Limits		Units
No. 3009			Min	Max	
Mounting					
Final Measurements	Capacitance	CA	Record	Values	
	Tangent of Loss Angle	tgδ	Not	te 1	
	Insulation Resistance	Rı	100	-	GΩ
Rapid Change of Temperature					
Initial Measurements	Capacitance	CA	Note	s 1, 2	
Final Measurements	Capacitance	C <sub>A</sub>	Not	te 1	
	Change in Capacitance	ΔC <sub>A</sub> /C <sub>A</sub>	-1	+1	pF or
			-1	+1	%
					(Note 3)
	Tangent of Loss Angle	tgδ	Not	te 4	
Steady State Humidity (85/85)					
Initial Measurements	Capacitance	CA	Note 1		
Final Measurements (1000 hours)	Capacitance	СА	Note 1		
,	Change in Capacitance	ΔC <sub>A</sub> /C <sub>A</sub>	-1	+1	pF or
			-2	+2	%
					(Note 3)
	Tangent of Loss Angle	tgδ	Not	te 4	
	Insulation Resistance (Note 5)	Rı	10	-	GΩ

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Test Reference per ESCC	Characteristics	Symbols	Limits		Units
No. 3009			Min	Max	1
Operating Life					
Initial Measurements	Capacitance	CA	Notes 1, 2		
Intermediate Measurements (1000 hours) (Note 6)	Capacitance	CA	Note 1		
	Change in Capacitance	ΔC <sub>A</sub> /C <sub>A</sub>	-1	+1	pF or
			-3	+3	%
					(Note 3)
	Insulation Resistance	Rı	10	-	GΩ
Final Measurements (1000 or 2000 hours) (Note 7)	Capacitance	CA	Note 1		
	Change in Capacitance	ΔC <sub>A</sub> /C <sub>A</sub>	-1	+1	pF or
			-3	+3	%
					(Note 3)
	Tangent of Loss Angle	tgδ	Note 4		
	Insulation Resistance	Rı	10	-	GΩ
	Voltage Proof	VP	$2.5U_{\text{R}}$	-	V
Temperature Characterisation	Insulation Resistance at T <sub>amb</sub> = +125 ±2°C	Rı	Note 8		
	Temperature Coefficient	TC	Note 8		
Robustness of Terminations					
Final Measurements	Capacitance	CA	Note 1		

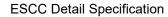
#### NOTES:

- 1. As specified in Para. 2.3.1 Room Temperature Electrical Measurements.
- 2. Capacitance values recorded during Mounting may be used as initial measurements.
- 3. Whichever is greater.
- 4. Twice the value specified in Para. 2.3.1 Room Temperature Electrical Measurements.
- 5. Test conditions for Insulation Resistance shall be as specified in Steady State Humidity in the ESCC Generic Specification.
- 6. Intermediate measurements are optional at the Manufacturer's discretion.
- 7. 1000 hours is applicable to Periodic Testing for extension of qualification. 2000 hours is applicable to Qualification Testing, and to Periodic Testing for renewal of qualification after lapse.
- 8. As specified in Para. 2.3.2 High and Low Temperatures Electrical Measurements.

#### 2.5 BURN-IN

The requirements for Burn-in are specified in the ESCC Generic Specification. The following conditions shall also apply:

 After Burn-in, the components shall be removed from the chamber and allowed to cool under normal atmospheric conditions for recovery for 24 hours minimum.



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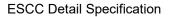




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# APPENDIX A AGREED DEVIATIONS FOR KYOCERA AVX COMPONENTS S.A.S. (F)

Items Affected	Description of Deviations
Para. 2.1.1 Deviations from the Generic Specification: Screening Tests - Chart F3	High and Low Temperatures Electrical Measurements: Temperature Coefficient may be replaced with data provided by the ceramic material supplier, using Kyocera AVX production documents 1J-ICONTDIE-630L and 1J-ICONTDIE-900L (issues as per PID).



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# <u>APPENDIX B</u> <u>AGREED DEVIATIONS FOR EXXELIA TECHNOLOGIES (F)</u>

Items Affected	Description of Deviations
Para. 2.1.1 Deviations from the Generic Specification: Screening Tests - Chart F3	Burn-in: Due to the use of components of varying designs to cover the available range of components as listed in REP005 (ESCC QPL), for any particular component, the Applied Voltage for Burn-in shall be as specified in the PID as agreed with the ESCC Executive, with a minimum value of 2 times the Rated Voltage (DC).